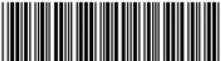


Search Notes



Application/Control No.

10/716,879

Examiner

ALEX LIU

**Applicant(s)/Patent under
Reexamination**

SCHEIER ET AL.

Art Un

2624

SEARCHED

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**